

PRODUCTION DATA SHEET

GENERAL DESCRIPTION

The LX1752 is a dual output mode PWM architecture.

The single input voltage supply feature simplifies the design and offers a wide range of operation from 4.5 to 22 volts. Each PWM has a Soft-Start pin for programming the output sequencing and serves as the shutdown control.

Current limit threshold is set with a single external resistor and protects the high-side and low-side MOSFETs by sensing the voltage drop generated from R_{DSON} .

Each PWM channel has its own input capacitor requirements. external feedback compensation for performance optimization.

synchronous buck controller using voltage for the external upper and lower N channel Internal gate drive circuitry provides 5V MOSFETS.

> Output voltages as low as 700mV, load currents up to 15A per phase and efficiency of 93% can be achieved with the flexible controller.

Operating alone or with other LX1752's on a bus, three multi-phase interleaving options are available: two PWM channels with 180° separation; three PWM channels at 120° or four PWM channels at 90°. This phasing is set by the tri-state input pin PSET. This architecture minimizes the

The entire power supply design occupies a small footprint with the LX1752's low profile 28 pin, MLP package of 4x5x1mm (JEDEC MO-220).

KEY FEATURES

- Dual PWM Controller,
- Synchronous Operation Voltage Mode PWM with
- External Compensation Single Input Supply, wide
- range 4.5V to 22V
- Precision Reference
- Outputs as low as 700mV Selectable PWM Frequency up to 1.5Mhz
- Synchronization Pin for PWM Frequency
- Independent and Programmable Soft Start/Enable for Power **Sequencing**
- Integrated High Current MOSFET Drivers
- Programmable Current Limit
- Lossless Current Sensing for Current Limit and Short Circuit Protection
- Pb-free, RoHS Compliant

APPLICATIONS

- Multi-Output Power Supplies
- Video Card Power Supplies
- PC Peripherals
- Set Top Boxes
- Point of Load DC-DC **Converters**

Copyright © 2007 Rev. 1.0, 2008-07-31 **L X 1 7 5**

WWW.

Microsemi .

COM

IMPORTANT: For the most current data, consult *MICROSEMI*'s website: **http://www.microsemi.com**

PGND L01 HR1 H01 VC1 VS1 CS1 SHDN1

PRODUCTION DATA SHEET

GND SYNC SHDN2 SSEN2 EA2- EO2 VIN CS2

⊃ \supset \supset

ABSOLUTE MAXIMUM RATINGS

Note: Exceeding these ratings could cause damage to the device. All voltages are with respect to Ground. Currents are positive into, negative out of specified terminal. x denotes respective pin designator (1 or 2).

THERMAL DATA

LQ Plastic MLPQ 28-Pin

THERMAL RESISTANCE-JUNCTION TO AMBIENT, θ**JA 27**°**C/W**

Junction Temperature Calculation: $T_J = T_A + (P_D \times \theta_{JA})$.

The θ_{JA} numbers are guidelines for the thermal performance of the device/pc-board system. All of the above assume no ambient airflow.

FUNCTIONAL PIN DESCRIPTION

MSC 1752 XXXX

VS2 VC2 H02

nnnn

칬 VCCL 102

LQ PACKAGE (Top View)

PACKAGE PIN OUT

SS
SPRES
HORE P
H H D 그 수 <u>그</u>
H H D 그 수 그

28 27 26 25 24 23

000000

LQ PACKAGE MARKINGS "xxxx" Denote Date Code and Lot Identification

RoHS / Pb-free 100% matte Tin Pin Finish

Microsemi Analog Mixed Signal Group 11861 Western Avenue, Garden Grove, CA. 92841, 714-898-8121, Fax: 714-893-2570

WWW.

Microsemi .

COM

PRODUCTION DATA SHEET

Note: X Denotes the PWM Channel: 1 or 2

PRODUCTION DATA SHEET

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, the following specifications apply over the operating ambient temperature $0^{\circ}C \leq T_A \leq 85^{\circ}C$ except where otherwise noted and the following test conditions: $V_{IN} = 12V$, $V_{CX} = 17V$, $HOX = 1000pF$ load to HRX, $LOX = 1000pF$ load to GND, $V_{HRX} = 12V$, (f = 800kHz).

PRODUCTION DATA SHEET

ELECTRICAL CHARACTERISTICS (CONTINUED)

Unless otherwise specified, the following specifications apply over the operating ambient temperature $0^{\circ}C \leq T_A \leq 85^{\circ}C$ except where otherwise noted and the following test conditions: $V_{IN} = 12V$, $V_{CX} = 17V$, $HOX = 1000pF$ load to HRX , $LOX = 1000pF$ load to GND, $V_{HRX} = 12V$, (f = 800kHz).

PRODUCTION DATA SHEET

SYSTEM CHARACTERISTICS

Unless otherwise specified, the following specifications apply over the operating ambient temperature 0°C $\leq T_A \leq 85$ °C except where otherwise noted and the following test conditions: $V_{IN} = 12V$; $f = 800kHz$; tested using the application circuit referenced in Figure 2.

Note 1: X denotes the PWM Channel: 1 or 2.

Note 2: Assured by design and characterization. Not ATE tested.

Note 3: For switching frequencies less than 800kHz, minimum pulse width is defined by the formula PW_{MIN} = 0.064 X 1/Fsw

Note 4: PSET Logic Threshold specifications are dependent on VCCL voltage level. The following formulas apply:

PSET Logic High min. threshold = 0.81 X VCCL + 0.140 (rising)

PSET Logic Low max. threshold = 0.19 X VCCL + 0.028 (rising)

Note 5: Guaranteed by design. Not ATE tested.

Page 6

PRODUCTION DATA SHEET

TYPICAL CHARACTERISTICS @ 25°C (REFER TO FIGURE 2)

PRODUCTION DATA SHEET

PRODUCTION DATA SHEET

PRODUCTION DATA SHEET

2

Copyright © 2007 Rev. 1.0, 2008-07-31

Page 10

PRODUCTION DATA SHEET

 APPLICATION CIRCUIT 5.0V @ 5 AMPS 5.0V @ 5 AMPS $3.3V@5$ AMPS 3.3V @ 5 AMPS \bigcirc vouti RTN \subset 10uF VOUT2 RTN 10uF J۱ + $O+12V$ 920uF
6.3V 3.3uH $\frac{1}{2}$ 820uF 6.3V ın 67 10uF ↓ 1/2 IRF8910 $\frac{2V}{2}$ œ 1/2 IRF8910 6 $\frac{1}{2}$ 1/2 IRF8910 3.3uH ่ 4 $\overline{2}$ ţ 67 $\overline{}$: ₽ 1/2 IRF8910 IRF8910 1/2 IRF8910 œ 21.0K 1% 1/2 IRF8910 N 4 $\overline{12}$ 0.1uF +5V LDO $\overline{0.1}$ uF CMDSH-3 CMDSH-3 CMDSH-3 CMDSH-3 2.32K $\frac{6}{3.40}$ K 1% 160K M P. 6.3V 4.7uF \mathbf{a} $|p|$ \mathbf{e} 17 $\frac{1}{2}$ 15 22 $\overline{\mathbf{z}}$ $\frac{1}{2}$ nF SHDN1 CS1 VS1 VC₁ e
Po ទី ∯ 0.1uF EO1 LO2 $\frac{1}{1.0}$ uF $\overline{\epsilon}$ 6 L EA1- **ACCF** \overline{v} 13 LX1752 **IN3SS** HR2 25 $\mathsf S$ 7. L RFREQ HO2 26 11 $\begin{matrix} 1 & 0 \\ 0 & 2 & 1 \end{matrix}$ PSET **Acz** $\overline{\mathcal{L}}$ 0 L **zs۸** $\overline{\overline{\overline{z}}}$ VREF 6 SHDN2 SSEN2 SYNC GND EA2- EO2 $\epsilon \overline{3}$ \rightarrow 2.32K ่ 50 œ 0.22uF $\frac{1}{2}$ $\frac{1}{\pi}$ ╢ 1.2nF $\breve{=}$ $+12V$ 21.0K 1% 4.7K 160K 5.62K 1% ⇩ +5V LDO TO ADDITIONAL LX1752'S TO ADDITIONAL LX1752'S **Figure 2 – LX1752** Application Schematic

Page 11

PRODUCTION DATA SHEET

THEORY OF OPERATION

DETAIL DESCRIPTION

The LX1752 is an independent dual-output, voltage-mode, Synchronous Buck controller integrated circuit. Output current sensing is through RDS_{ON} measurement of the external power MOSFETs, and is set by a single userprogrammable resistor for each output. The internal PWM clock frequency is user programmable from 200kHz to 1.5MHz, via a single programming resistor. Synchronizing of the internal PWM clock is possible for multiple LX1752 ICs using either an internally generated sync pulse, or a sync signal from an external source. Synchronized LX1752 IC's PWM outputs can be phase positioned relative to each other via a single pin configuration, allowing 90°, 120°, or 180° phase separation between outputs. Each of the two LX1752 outputs has external feedback compensation, for flexibility of output filter component selection.

OSCILLATOR FREQUENCY

The LX1752 IC's internal PWM oscillator is userprogrammable from 200kHz to 1.5MHz. Programming is provided by a single resistor, R_{FREO} , connected between the RFREQ and GND pins. The value of this resistor is based on the following formula:

$$
R_{\text{FREG}}(K\Omega) = \frac{1}{27.56E^{-9} \times F_{\text{OSC}}} - 5.156
$$

EXTERNAL CLOCK SYNCHRONIZATION

The LX1752 provides external clock synchronization of the PWM clock, for multiple LX1752 ICs. This feature is implemented via a common buss connected to the LX1752 IC's SYNC pin. The SYNC pin is an I/O pin, with an open drain switch to ground providing the internally-generated output sync pulse. This allows each LX1752 SYNC pin to connect to a common buss in a wired-OR configuration. For proper operation, a pull-up resistor between the LX1752 IC's VCCL and SYNC pins must be provided. The total parallel pull-up resistance must be greater than 500 Ohms for all ICs connected to the common buss. The total pull-up resistance on the SYNC pins is sized such that the sync pulse rise time is (at maximum) less than $\frac{1}{2}$ the PWM clock period. Under synchronized operation, each LX1752 is synchronized to the falling edge of the sync pulse. Multiple LX1752 ICs will synchronize to the controller with the highest PWM clock frequency. For proper operation, it is advised to set one controller's PWM frequency 15% higher than the others to insure it will always provide the master clock frequency.

An externally generated clock pulse may be used to synchronize multiple LX1752 ICs. The LX1752 synchronizes to an external signal by resetting the PWM ramp on the falling edge of the signal input at the SYNC pin. When using an external clock for synchronizing, the external clock should be provided through an open drain or open collector connection, with an external pull-up resistor between the SYNC and VCCL pins. . For proper operation, the external clock frequency must be at least 15% higher than the LX1752 internal PWM frequency set by R_{FEREO} , and external clock widths should be less than ½ the nominal period set by R_{FRED} . Figure 3 and 4 are an example of an external sync circuit and the resultant waveforms at the moment of sync clock capture.

PRODUCTION DATA SHEET

THEORY OF OPERATION

OUTPUT PHASE POSITIONING

The LX1752 offers phase positioning of the output PWMs. Using two synchronized LX1752 controllers, up to four PWM outputs may be interleaved at 90° intervals or 3 PWM outputs at 120° intervals. Output phase positioning relative to the SYNC pin signal can be configured via the LX1752's PSET pin. The PSET pin is a tri-mode input pin, whose state determines the PWM output's phase relationship.

OVER-CURRENT PROTECTION AND HICCUP MODE

The LX1752 senses the $R_{DS(ON)}$ of both the upper (Control) and the lower (Synchronous) MOSFET for current limit detection. RDS_{ON} Sensing is done via three pins: CS_X , VS_{X} , and PGND. The upper (Control) FET RDS_{ON} is sensed via the CS_X and VS_X pins. The lower (Synchronous) FET RDS_{ON} is sensed via the CS_X and PGND pins. Current limit is set by the resistor on the CS_x pin, and is based on the following calculation:

$$
R_{CS} = \frac{I_{LIM} \times RDS_{ON}(max)}{I_{cs}(min)}
$$

Where I_{CS} (min) = minimum CS pin programming current

The upper and lower MOSFET current sense contain an internal blanking circuit which delays current sensing for 150ns after their respective MOSFET is switched on. This reduces possible false current limit detection due to ringing. R_{CS} values should be chosen such that delays created by the CS_X resistor and any PCB capacitance on the CS_X pin are less than 100ns; this is to insure the CS_x pin voltage rises faster than the current sense blanking time.

For best operation of the LX1752 current sense circuit, the VS_X pin and CS_X resistor must be Kelvin-connected to their respective output MOSFET Drain and Source pins. When an over current limit is detected, a signal to reset the PWM latch is generated, and the output PWM is truncated on a cycle by cycle basis. After 4 continuous PWM cycles of current limit detection, hiccup mode is started. At the initial start of hiccup mode, the HO_X output MOSFET for that phase is held

off, and the soft-start capacitor (C_{SS}) is discharged at a rate 1/25 of the soft-start rate. When the SS pin voltage decreases to the 0.1V PWM enable threshold, the hiccup mode cycle "off time" finishes, the output PWM is switched on, and the circuit soft-starts again. During the soft start period, Hiccup mode is disabled, however, cycle by cycle current limit is functional, insuring output current is kept at the current limit setting. Once $SSEN_X$ reaches 720 mV (90% of the 800mV $SSEN_X$ pin reference voltage), if an over current condition still exists, hiccup mode will again be initiated, the SS capacitor will discharge, and the PWM output will be switched off until the SS voltage decreases to 0.1V. The low duty cycle of hiccup mode, in combination with cycle by cycle current limiting, reduces the power dissipation of the output MOSFETs during a fault condition, thus providing a very reliable and robust overload and short circuit protection

INTERNAL LDO REGULATOR

The LX1752 contains a +5V LDO regulator for providing power to internal circuits, external flying bootstrap capacitors, MOSFET gate drives, and pull-up resistors for the SYNC and SHDN pins. The +5V LDO output is available at the VCCL pin. For proper operation, a minimum 4.7uF capacitor is required between the VCCL and GND pins. Total continuous LDO current should be limited to 100mA.

UNDER VOLTAGE LOCKOUT (UVLO)

At power up, the LX1752 monitors the internal LDO voltage at the VCCL pin. The VIN supply voltage has to be sufficient to produce a voltage greater than the UVLO threshold at the VCCL pin before the controller will come out of the under-voltage lock-out state. At VCCL voltages below the UVLO threshold, Both soft-start (SS) pins are held low, the internal PWM oscillator is disabled, and all MOSFETs are held off.

SOFT-START

Once the VCCL output is above the UVLO threshold, a capacitor connected between the SS_X and GND pins begins charging by a $20k\Omega$ internal resistor connected to an $800mV$ reference. The capacitor voltage at the SS pin rises as a simple RC circuit. The voltage at the SS pin controls its respective output voltage through the error amplifier's noninverting input. The output voltage will follow the SS pin voltage if sufficient charging current is provided to the output capacitor. Due to the exponential rise of the SSX pin voltage, the fastest output voltage rate of rise occurs during the first time constant of the SSX capacitor, and the internal 20KΩ resistor. During this period, the feedback reference voltage will reach 63% of its nominal setting. This rate of rise can be

PRODUCTION DATA SHEET

THEORY OF OPERATION

used to calculate the average startup current seen by the inductor:

$$
\text{I}_{\text{STARTUP}} = \text{C}_{\text{OUT}} \, \frac{.63 \times \text{V}_{\text{OUT}}}{20\text{E}^3 \times \text{C}_{\text{SS}}} + \text{I}_{\text{LOAD}}
$$

For lowest in-rush currents, soft start capacitors should be sized such that the output voltage rise is slower than the input voltage (VIN) rise during power-up.

EXTERNAL PWM ENABLE

The LX1752's PWM outputs can be disabled externally by holding the SS_X pin below 0.1V with an open drain transistor connected to ground. At SS_x pin \leq 0.1V, both output MOSFETS are held off. Using this method, PWM enable

and soft start can be controlled through an external signal. This method is useful for controlled power-up sequencing.

BUFFERED VREF OUTPUT

The LX1752 provides a buffered output of the internal 800mV reference. This output may be used as a reference for an external LDO or any application where an 800mV reference is required. Current is limited to a maximum of 1mA from this output.

EXTERNAL FEEDBACK AND COMPENSATION COMPONENTS

The LX1752 has pin access to each output's respective error amplifier inverting and output signals. This topology offers full freedom for output filter component selection and control loop optimization for stable high bandwidth operation. See compensation section below.

WWW.

Microsemi .

COM

PRODUCTION DATA SHEET

APPLICATION INFORMATION

OUTPUT INDUCTOR SELECTION

The Output Inductor value is selected based on the desired ripple current. Inductor Ripple current should be in the range of 20% to 40% of the maximum output current. Higher inductance values result in lower peak to peak ripple current, at the expense of slower transient response. Lower inductor values provide a higher current slew rate in response to a step change in load current, however peak to peak ripple current increases, requiring an output filter capacitor with a smaller ESR specification to meet output ripple voltage requirements. The Inductor value can be calculated by:

$$
L = \frac{V_{\text{IN}} - V_{\text{OUT}}}{I_{\text{RIPPLE}}} \times \frac{D}{F_{\text{SW}}}
$$

Where $D =$ Operating Duty Cycle F_{SW} = PWM Switching Frequency I_{RIPPLE} = Desired Peak to Peak Ripple Current

OUTPUT CAPACITOR SELECTION

The key selection parameters for the output capacitor are the actual capacitance value, the equivalent series resistance (ESR), the equivalent series inductance (ESL), and the voltage rating requirements, which affect overall stability, output ripple voltage, and step load transient response.

The output ripple has three components: variation in the charge stored in the output capacitor, the voltage drop across the ESR, and the voltage drop across the ESL, caused by the current into and out of the capacitor. The following equations estimate the worst-case output ripple voltage:

$$
V_{\text{RIPPLE}} = V_{\text{RIPPLE(ESR)}} + V_{\text{RIPPLE(C)}} + V_{\text{RIPPLE(ESL)}}
$$

Where:

$$
V_{\text{RIPPLE(ESR)}} = I_{\text{RIPPLE}} \times ESR
$$

$$
V_{\text{RIPPLE}(C)} = \frac{I_{\text{RIPPLE}}}{8 \times C \times F_{\text{SW}}}
$$

$$
V_{\text{RIPPLE}(ESL)} = \frac{V_{\text{IN}} \times ESL}{L + ESL}
$$

High output current may require paralleling multiple capacitors to meet output ripple requirement, as it reduces ESR and ESL, which are the major contributors to output ripple voltage.

For step load conditions, capacitor ESR will be the dominant factor determining the size of the initial output voltage excursion. Capacitor ESR should be selected such that:

$$
ESR \times (I_{RIPPLE} + \Delta I) < V_{TRANSIENT}
$$

Where I_{RIPPLE} = peak to peak inductor ripple current ΔI is the maximum load current step change $V_{\text{TRANSIENT}}$ is the maximum allowed output voltage excursion during a load step change

A second consideration when determining the output capacitor is the minimum capacitance value required to limit voltage overshoot during a large load release, such as a transient from full load to no load. In this case, the output capacitor must be large enough to absorb the excess energy present in the inductor. Minimum output capacitance is based on the desired maximum overshoot and output inductor value, and is calculated by the following formula:

$$
C_{\text{MIN}} = \frac{(\mathbf{I}_{\text{TRAN}})^2 \times \mathbf{L}}{(\mathbf{V}_{\text{OUT}} + \mathbf{V}_{\text{OVERSHOOT}})^2 - \mathbf{V}_{\text{OUT}}^2}
$$

Where I_{TRAN} = specified maximum load transient (full load to no load)

$$
L
$$
 = output inductor value

 $V_{over^S} = maximum allowable voltage overshoot$ </u></sup>

INPUT CAPACITOR SELECTION

RMS ripple current is the primary factor when selecting the input capacitor. Input RMS ripple current is based on operating duty cycle (D), and is at a maximum at $D = 50\%$.

The following formula is used for calculating the input RMS current for each output:

$$
I_{INRMS} = I_{OUT(MAX)} \times \frac{\sqrt{V_{OUT}(V_{IN}-V_{OUT})}}{V_{IN}}
$$

PRODUCTION DATA SHEET

APPLICATION INFORMATION

Input capacitance is largely dependent on the source impedance of the power source; however, for most cases the general rule of thumb is to use a total minimum capacitance of 10uF for every ampere of input ripple current. This is best achieved through a combination of ceramic capacitors placed as close to the output FETS as possible, and an electrolytic capacitor placed in close proximity to the LX1752 and it's associated circuit components.

FEEDBACK AND COMPENSATION COMPONENT SELECTION

The LX1752 is a voltage mode controller that uses external feedback components to establish output DC voltage and closed-loop bandwidth. This control scheme consists of an error amplifier, whose output controls a PWM modulator, which in turn drives an LC filter to produce the DC output (See Figure 5). A simple way to analyze the closed loop system is to break the loop and separate the elements into two sections: first, the combined PWM modulator and output LC filter, called the Control To Output section, and second, the Error Amplifier section (See Figure 6). Once separated, the total gain through the two sections is analyzed.

Figure 6. Separating the Loop Components

To achieve a proper closed loop system, first the crossover frequency is determined, after which the Control To Output Section is analyzed for it's gain and rolloff response at that frequency. Once the response at the crossover frequency is known, the error amplifier compensation components are chosen such that the overall gain of the two sections is equal to 1 (or 0dB) at the crossover frequency:

$$
G_{FC} = G_{CTO} \times G_{EAXO} = 1
$$

Where G_{FC} = loop gain at crossover frequency
 G_{CTO} = Control To Output Section Gain at crossover
frequency

 G_{EAXO} = Error Amplifier Section Gain at crossover frequency

The LC filter creates a complex pole (-2 Slope) in the Control To Output Section's response, along with a zero created by the output capacitor ESR. So, in addition to the Gain of 1 at the crossover frequency, the phase response of the Error Amplifier Section must be designed such that the response of the Control To Output Section is compensated to achieve a first order response (-1 slope) at the crossover frequency (See Figure 7). This will insure that the phase margin at the crossover frequency is greater than 45°. This is accomplished by designing the Error Amplifier's response to counteract the pole and zero created by the output LC filter.

WWW.*Microsemi .***COM**

PRODUCTION DATA SHEET

APPLICATION INFORMATION

When selecting feedback and compensation components, the following steps are required:

- 1) Determine the input resistor value.
- 2) Determine the output voltage setting resistor.
- 3) Determine the Control-To-Output gain at the desired crossover frequency.
- 4) Determine the Error Amplifier gain at the desired crossover frequency.
- 5) Decide if Type Two or Type Three compensation is used
- 6) Calculate the feedback components for the desired compensation type.

1. DETERMINE THE INPUT RESISTOR VALUE:

The input resistor is sized based on the error amplifier input bias current specification. High bias currents can create output voltage errors in large-value input resistors due to the IR drop created by this current. The LX1752 has a specified input bias current of 30nA (max.). This will generate a 30uV (max.) output voltage error for every 1k Ω of input resistance. This error is small enough to neglect in most cases. For this example, use 21kΩ (See Figure 8).

2. DETERMINE THE OUTPUT VOLTAGE SETTING RESISTOR:

The voltage setting resistor is the resistor connected between the error amplifier's inverting input and ground. This resistor, in conjunction with the input resistor, forms a DC voltage divider that determines the output voltage level (see Figure 8). Because the voltage divider is connected to the input of the error amplifier, the control loop will force the DC output voltage such that the voltage developed across the setting resistor will equal the feedback voltage reference, V_{FB} . V_{FB} for the LX1752 is specified at a nominal 0.7V at room temperature. The following equation determines the voltage setting resistor:

$$
\text{(Equation 1)} \qquad \mathbf{R}_{\text{SET}} = \frac{\mathbf{R}_{\text{INPUT}} \times 0.7}{\mathbf{V}_{\text{OUT}} - 0.7}
$$

For our example, If $R_{INPUT} = 21k\Omega$, and desired $V_{OUT} = 5V$, then $R_{SET} = 3.42$ kΩ.

3. DETERMINE THE CONTROL TO OUTPUT GAIN AT THE DESIRED CROSSOVER FREQUENCY:

The first step in determining the control to output gain is to decide on the closed-loop bandwidth, or crossover frequency of the system. Bandwidths that are too wide (high crossover frequency) can amplify switching noise. Bandwidths that are too low will have poor transient response times.

The general rule-of-thumb is that the crossover frequency (F_C) should be no greater than $1/5th$ the switching frequency, or :

(Equation 2)

 $F_c \leq \frac{F_{\text{SW}}}{c}$

The error amplifier gain will limit the maximum crossover frequency. The total bandwidth capable will be based on the output filter components, the DC input voltage, and the error amplifier gain. A good rule of thumb would be to limit the bandwidth to 100kHz or less.

Once the crossover frequency has been determined, the next step is to determine the total input to output gain of the Control to Output Section at the crossover frequency. The input to output gain expression for the Control to Output Section is:

L

PRODUCTION DATA SHEET

APPLICATION INFORMATION

(Equation 3) $G_{CTO} = V_{IN} \times G_{PWM} \times G_{LC}$

Where $V_{IN} = DC$ input voltage to the output Mosfets $G_{\text{PWM}} = \text{PWM Modulator Gain}$ G_{LC} = Output LC filter Gain

The PWM Modulator Gain is based on the peak to peak PWM ramp voltage, and is simply:

(Equation 4)

$$
\mathbf{G}_{\mathsf{PWM}} = \frac{1}{\mathsf{V}_{\mathsf{RAMP}}}
$$

Where V_{RAMP} = the peak to peak ramp amplitude

The LX1752 has a nominal ramp amplitude $= 1.2V$

The output LC filter creates two frequency corners in the output response: First, a complex pole with -2 slope (40dB/Decade) rolloff and 180° phase shift is created at the LC resonance frequency. Second, a zero, is created at the output capacitor and its respective Equivalent Series Resistance (ESR) corner frequency.

These two frequency corners are found by the following equations:

(Equation 5)

 $F_P = \frac{1}{2\pi\sqrt{LC}}$ = 2 1 And

(Equation 6) $F_Z = \frac{1}{2\pi (RC)}$

Where $L =$ Output Filter Inductor $C =$ Output Filter Capacitor R = Output Filter Capacitor ESR

At the crossover frequency, the LC filter's response can be found using the calculated pole and zero. This method of calculating the response will depend on the relationship of the output capacitor-ESR zero corner frequency to the chosen crossover frequency:

Or

(Equation 7) $G_{LC} = \frac{P}{(F_Z \times F_C)}$; $F_Z \le F_C$ $G_{LC} = \frac{F_P^2}{(F_Z \times F_C)}$; $F_Z \le F_C$

$$
\text{(Equation 8)} \qquad \mathbf{G}_{\text{LC}} = \left(\frac{\mathbf{F}_{\text{P}}}{\mathbf{F}_{\text{C}}}\right)^2; \mathbf{F}_{\text{Z}} > \mathbf{F}_{\text{C}}
$$

Example Calculations:

Using the application circuit:

 V_{IN} = 12V $L = 3.3uH$ $C= 820$ uF $ESR = 21m\Omega$ Ramp Amplitude = 1.2V Crossover Frequency = 80kHz Using equations 5 and 6, find the pole and zero frequency corners:

$$
F_{\rm p} = \frac{1}{2\pi\sqrt{3.3E^{-6} \times 820E^{-6}}} = 3.06 \text{kHz}
$$
\n
$$
F_{\rm z} = \frac{1}{2\pi \times 21E^{-3} \times 820E^{-6}} = 9.25 \text{kHz}
$$

The ESR-capacitor zero frequency of our example is less than the crossover frequency. Use equation 7 to determine the LC filter gain at the crossover frequency:

$$
G_{LC} = \frac{3.06 \text{kHz}^2}{9.25 \text{kHz} \times 80 \text{kHz}} = 12.65 E^{-3}
$$

The PWM Modulator gain is found using equation 4:

$$
G_{\text{PWM}} = \frac{1}{1.2} = 833E^{-3}
$$

Using Equation 3, the total Control to Output Section gain at the crossover can be determined:

$$
G_{\text{CTO}} = 12 \times 833E^{-3} \times 12.65E^{-3} = 126.45E^{-3}
$$

4. DETERMINE THE ERROR AMPLIFIER GAIN AT THE DESIRED CROSSOVER FREQUENCY:

Our example Control to Output Section gain is 0.12645 at the crossover frequency. The error amplifier gain required for unity gain at the crossover frequency will be:

Microsemi Analog Mixed Signal Group 11861 Western Avenue, Garden Grove, CA. 92841, 714-898-8121, Fax: 714-893-2570

PRODUCTION DATA SHEET

APPLICATION INFORMATION

(Equation 9)
$$
G_{EAXO} = \frac{1}{G_{CTO}} = \frac{1}{126.45E^{-3}} = 7.908
$$

Once the required Error Amplifier gain is determined, the Error Amplifier open loop gain should be examined to assure the Error Amplifier has enough open-loop gain at the crossover frequency to satisfy the above gain requirement:

$$
\begin{aligned} \text{(Equation~10)} \quad G_{\text{EAXO}} \leq \frac{G_{\text{EAOL}}}{\left(\frac{G_{\text{EAOL}} \times 2\pi \cdot F_{\text{C}}}{2\pi \cdot F_{\text{EAOL}}}\right) + 1}\end{aligned}
$$

Where G_{EAOL} = Error Amplifier Open Loop Gain F_{FAOL} = Error Amplifier Open Loop Bandwidth

Using the LX1752 Error Amplifier as an example:

 $G_{EAOL} = 70dB$, gain magnitude = 3162 $F_{EAOL} = 10 MHz$

$$
\frac{3162}{\left(\frac{3162 \times 2\pi \times 80 \text{kHz}}{2\pi \times 10 \text{MHz}}\right) + 1} = 120.24
$$

The above equation shows there is ample Error Amplifier open-loop gain available at the crossover frequency.

5. DECIDE IF TYPE TWO OR TYPE THREE COMPENSATION IS USED.

At this point, the compensation type can be decided. The two standard methods for compensating a Voltage Mode Buck converter are Type Two and Type Three compensation (the name references the number of compensating slopes in the response; Type Two has two, Type Three has three). See Figures 9 & 10. Both Type Two and Type Three compensation are identical in that they are designed to offset the complex pole and ESR zero of the output LC filter. Where they differ is in the number of compensating poles and zeros provided. Type Two compensation is known as a "single pole-zero" compensation, in that it supplies a single compensating zero, and a single compensating pole in the Error Amplifier's response. The Type Three compensation is known as "pole-zero pair" compensation, in that it supplies two compensating poles and two compensating zeros. The deciding factor for which of the two methods of compensating the loop can be used is based on the amount of

available phase margin present in the Control to Output Section at the crossover frequency. Because Type Two compensation does not provide an extra phase boost after the complex LC pole, the phase boost provided by the output capacitor – ESR combination is critical when using Type Two compensation. Therefore, the relationship of the complex LC pole, F_{P} , to the ESR-capacitor zero, F_{Z} , becomes important: if Fz/Fp is 5 or less, then Type Two Compensation may be used. Type Three compensation should be used otherwise.

PRODUCTION DATA SHEET

APPLICATION INFORMATION

TYPE THREE COMPENSATION COMPONENT SELECTION.

Type Three compensation contains 2 poles and 2 zeros in the feedback loop to counteract the complex pole created by the L-C output filter, and the zero created by the ESR output capacitor. Type 3 compensation should be used when the desired crossover frequency is lower than the ESR zero frequency, or when it is higher than the ESR zero frequency and the ESR zero frequency is higher than 4 to 5 times the output LC filter corner frequency. Typical feedback response is shown in Figure 11.

Figure 11. Typical Type 3 Feedback Response

To calculate the values, first the two compensation zeros and two compensation poles must be set.

The two compensation zeros are set to counteract the complex L-C pole at two locations, both multiples of the complex L-C pole:

1. Set the first compensation zero frequency (fz1) to the L-C pole/4:

(Equation 11)

 $f_{Z}1 = \frac{F_{P}}{4}$

2. Set the second compensation zero frequency (f_Z2) equal to the L-C pole frequency:

(Equation 12) $f_z = F_p$

$$
f_{Z}2=F
$$

3. Next, the first compensation pole (f_P1) is set equal to the ESR - capacitor zero frequency:

(Equation 13) $f_p 1 = F_z$

4. Finally, the last compensation pole
$$
(f_P2)
$$
 is set equal to $1/2$ the switching frequency:

(Equation 14) $f_P 2 = \frac{F_{SW}}{2}$

In order for the feedback response to be correct, the feedback loop must be set to two gain levels, $G_{FB}1$, and $G_{FB}2$

 $G_{FR}2$ is the highest gain value of the two levels, and is the gain required to boost the control to output gain to 1 at the crossover frequency. $G_{FB}2$ is established after the first compensation pole frequency (f_P1) , and is the complement of the total control to output gain (G_{CTO}) at the selected crossover frequency:

$$
(Equation 15) \t G_{FB} 2 = \frac{1}{G_{CTO}}
$$

 $G_{FB}1$ is the gain level established after the first compensation zero frequency (fz1). $G_{FB}1$ gain is derived from the crossover frequency gain ($G_{FB}2$). The method for calculating $G_{FB}1$ is dependent on whether the output capacitor – ESR zero corner frequency is greater or less than the crossover frequency.

Condition 1;
$$
F_Z \leq F_C
$$

 $(Equation 16)$ G

$$
G_{FB}1 = G_{FB} 2 \times \left(\frac{f_z 2}{f_p 1}\right)
$$

Condition 2; $F_C \leq F_Z$

This condition occurs when the capacitor-ESR zero frequency corner is greater than the chosen cutoff frequency. This is a common condition with ceramic output capacitors. For this condition, $G_{FB}1$ is found by:

$$
(Equation 17) \tG_{FB}1 = G_{FB}2 \times \left(\frac{f_z 2}{F_c}\right)
$$

To calculate the compensation component values (Reference Figure 9):

First, select resistor R1. This topic is covered under "Determine the Input Resistor Value" on page 17. Resistor R4 may be selected at this time; however it is for setting the output DC level only, and is not used in the compensation calculations. R4 is covered under "Determine the Output Voltage Setting Resistor" on page 17.

Copyright © 2007 Rev. 1.0, 2008-07-31

PRODUCTION DATA SHEET

APPLICATION INFORMATION

Next, calculate the value of R2; R1 & R2 will set the gain for $G_{FR}1$:

(Equation 18) $R2 = R1 \times G_{FB}1$

Calculate the value for C1; C1 $& R2$ set the first zero Referencing Figure 7: frequency:

(Equation 19) $C1 = \frac{1}{2\pi (f_z 1)R2}$ π _Z =

The next value is for R3; R3||R1 & R2 set the gain for G_{FB} 2:

(Equation 20) $R3 = \frac{R1 \times R2}{(R1 \times G_{FB} 2) - R2}$

Calculate C2; C2 & R1 + R3 set the second zero frequency:

(Equation 21) $C2 = \frac{1}{2\pi(f_z 2)(R1 + R3)}$

Finally, the value for $C3 + C1$ & R2 sets the second pole frequency:

(Equation 22) $\qquad \qquad$ C3 = $\frac{C1}{(2\pi (f_P 2) \cdot C1 \cdot R2) - 1}$

The first pole frequency, f_P1 , will be correct with the values chosen. To verify:

$$
\text{(Equation 23)} \qquad \mathsf{f}_\mathsf{P} \mathsf{1} = \frac{1}{2\pi(\mathsf{R}3\mathsf{C}2)}
$$

Example Calculations:

Assume the following design parameters and component values:

- $V_{\text{IN}} = 3.4V$
- $V_{\text{OUT}} = 1.24V$
- V_{RAMP} = 1.2V
- PWM frequency = 800kHz
- Error Amplifier Gain = 3162 (70dB)
- Error Amplifier Bandwidth = 10MHz
- Output Inductor $(L) = 2.2$ uH
- Output Capacitor $(C) = 3000$ uF $(2 \text{ X } 1500$ uF capacitors in parallel)
- Capacitor ESR = $5.5 \text{m}\Omega$ (2 capacitor ESR values of $11mΩ$ in parallel)
- Crossover Frequency = 80kHz

Step 1 – Determine the input resistor $(R1)$ value:

- Keep the input resistor value as low as practical to reduce input bias errors. For this example, choose 10.7kΩ 1% (1% part for DC output voltage accuracy).
- Step 2 Determine the DC output "setting" resistor (R4): Using Equation 1, and the values chosen for R_{INPIIT} and V_{OUT} :

R_{SET} (R4) = 13.6kΩ. Use 13.7kΩ 1% (1% part for DC output voltage accuracy).

Step 3 – Determine the Control to Output Section Gain:

Using Equation 5, and the values chosen for L and C: $F_P = 1.96kHz$

Using Equation 6, and the values chosen for ESR and C:

 F_Z = 9.65 kHz

The ESR – Capacitor zero frequency is less than the chosen crossover frequency. Use Equation 7 to calculate the gain of the LC filter section:

 $G_{LC} = 4.974E - 3$

Using Equation 4, PWM modulator gain is:

 $G_{\text{PWM}} = 0.833$

Finally, using Equation 3 and the chosen VIN value of 3.4V:

 $G_{CTO} = 14.086E - 3$

Step 4 - Determine required Error Amplifier Gain:

Using Equation 9, the required Error Amplifier Gain: $G_{EAXO} = 71$

Use Equation 10 to determine the Error Amplifier open-loop gain at the crossover frequency:

 $G_{EAXO} \leq 120.2$

Based on equation 10, there is enough gain available.

- Step 5 Determine Type Two or Type Three compensation: For this example, F_Z/F_P is greater than 4. We will use Type Three Compensation.
- Step 6 Select Type Three components (reference Figure 9): Using Equations 11 through 14, determine the compensation frequency components: $fz1 = 490Hz$

PRODUCTION DATA SHEET

Figure 13 is the Bode Plot of the closed loop response of our

APPLICATION INFORMATION

example.

- $fzz = 1.96kHz$ $fp1 = 9.65kHz$
- $fp2 = 400kHz$

Calculate the highest of the two feedback gains using Equation 15:

 $G_{FB}2 = 71$

The ESR – Capacitor zero frequency is less than the chosen crossover frequency. Use Equation 16 to calculate the lower of the two feedback gains:

 $G_{FB}1 = 14.4$

Using Equations 18 through 22, calculate the values for the compensation components:

R2 = 154k Ω ; use 150k Ω 5%

 $R3 = 2.72$ kΩ; use 2.7kΩ 5%

 $C1 = 2.11$ nF; use 2.2nF

 $C2 = 6.05$ nF; use 5.6nF

 $C3 = 2.6pF$; too small; omit this capacitor.

In this example, C3 value of 2.6pF is far too small to be of practical use. In this case it may be omitted without any consequence. If the additional roll off provided by C3 is still desired, the value of R_{INPUT} (R1) may be set lower, and the feedback components recalculated. This will raise the value of C3. As an alternative, set F_P2 to a lower frequency, however do not set lower than 1.5 X the crossover frequency (F_C) . Figure 12 is the schematic of the example feedback compensation.

Figure 13. Bode Plot of Example Circuit

L

PRODUCTION DATA SHEET

APPLICATION INFORMATION

TYPE TWO COMPENSATION COMPONENT SELECTION.

Type Two compensation contains a single zero and pole in the feedback loop to counteract the complex pole created by the L-C output filter. This type of compensation does not provide an extra phase boost after the complex LC pole frequency, which is provided by Type 3 compensation. This type of compensation is used when the phase margin of the Control to Output section is greater than the minimum closed loop phase margin desired at the crossover frequency. Typical frequency response is shown in Figure 14.

Figure 14. Typical Type 2 Feedback Response

The component values for Type 2 compensation are found using identical equations and methods as in Type 3. The main differences are that Type 2 has only one gain level, one compensating zero, and one compensating pole to calculate.

As in Type 3 Compensation, establish the frequency corners:

1. Set the first compensation zero frequency (fz1) to the L-C pole/4:

$$
\text{(Equation 24)} \quad f_z \mathbf{1} = \frac{\mathbf{F}_{\mathrm{p}}}{4}
$$

2. Set the compensation pole (f_P1) equal to $1/2$ the switching frequency:

$$
\text{(Equation 25)} \quad f_{\text{P}} \, 1 = \frac{F_{\text{SW}}}{2}
$$

Type Two compensation has only one gain level to be concerned with. This is the gain required to boost the control to output gain to 1 at the crossover frequency:

$$
(Equation 26) \t G_{FB} = \frac{1}{G_{CTO}}
$$

To calculate the compensation component values (Reference Figure 8):

First, select resistor R1. This topic is covered under "Determine the Input Resistor Value" on page 15. Resistor R3 may be selected at this time; however it is for setting the output DC level only, and is not used in the compensation calculations. R3 is covered under "Determine the Output Voltage Setting Resistor" on page 16.

Next, calculate the value of R2; R1 & R2 will set the gain for G_{FB} :

$$
(Equation 27) \t\t R2 = R1 \times G_{FB}
$$

Calculate the value for C1; C1 $\&$ R2 set the compensating zero frequency:

(Equation 28)
$$
C1 = \frac{1}{2\pi(f_z 1)R2}
$$

Finally, the value for C2 + C1 & R2 sets the compensating pole frequency:

(Equation 29) $C2 = \frac{C1}{(2\pi(f_P 1) \cdot C1 \cdot R2) - 1}$

PRODUCTION DATA SHEET

APPLICATION INFORMATION

OUTPUT MOSFET SELECTION

When selecting output MOSFETs, There are five important parameters to be concerned with: Maximum V_{DS} rating, Maximum Drain Current rating, RDS_{ON}, Total Gate Charge, and Maximum Power Dissipation.

The upper and lower MOSFET positions, in many cases, can be satisfied with the same part value FET, making the use of dual MOSFET packages attractive. However, in cases where output current and switching frequency are high, the MOSFET chosen for the upper (Control) FET may differ from the lower (Synchronous) FET.

For example, in a high frequency switcher application, the power dissipated in the Control FET may be more dependent on switching losses, in which case a FET with a lower total gate charge (Qg) should be considered. The opposite is true for the Synchronous FET, where conduction losses may be the dominating factor in the total power dissipation. In this case a FET with a lower RDS_{ON} would be considered.

The maximum V_{DS} rating of the MOSFET should exceed by at least 10% the maximum DC input voltage, plus any voltage transients that might be present on the DC line, over all operating temperatures.

The maximum drain current rating of the MOSFET should be chosen to cover all operating current conditions, at all operating temperatures. Overcurrent limits, and current spikes should all be considered before selecting a MOSFET.

 RDS_{ON} and total gate charge should always be as small as possible. RDS_{ON} and total gate charge (Qg) will vary inversely with each other; ie. lower gate charges typically are at the expense of higher RDS_{ON} ratings.

MOSFETs must be chosen such that their maximum power dissipation is not exceeded at any time in the application, and that the junction temperature for the device does not exceed the maximum rating for the part under all conditions. The power dissipation of the MOSFET will depend largely on two principle factors affecting loss: conduction losses, and switching losses.

At lower frequency switching, conduction losses make up the bulk of the total power dissipation in the MOSFETs. Two factors determine conduction losses: channel conduction losses (for both Control and Synchronous FETs), and body diode conduction losses (Synchronous FET only).

For conduction losses in the Control (Upper) FET, channel loss is the only concern (under normal operation the body diode does not conduct). Channel loss is due to the IR drop across the MOSFET's RDS_{ON} . When calculating channel loss, RDS_{ON} should be specified at the maximum junction temperature of the FET. Most datasheets specify RDS_{ON} at 25° C, and provide a graph for estimating the RDS_{ON} at a specific junction temperature. Channel loss for the upper FET ($PD_{RDS(CONTROL)}$) can be calculated with the following formula:

(Equation 30)

$$
PD_{\text{RDS}(\text{CONTROL})}(W) = \frac{\left(I_{\text{LOAD}}\right)^2 \times \text{RDS}_{\text{ON}} \times V_{\text{OUT}}}{V_{\text{IN}}}
$$

Note: specify RDS_{ON} at maximum junction temperature. For conduction losses in the Synchronous (Lower) FET, both channel and body diode losses must be considered. As in the Control FET calculations, channel loss is a function of RDS_{ON} , and should be evaluated using the specified RDS_{ON} at the part's specified maximum junction temperature:

(Equation 31)

$$
PD_{\text{RDS(SYNC)}}(W) = (I_{\text{LOAD}})^2 \times \text{RDS}_{\text{ON}} \times \left(1 - \frac{V_{\text{OUT}}}{V_{\text{IN}}}\right)
$$

Note: specify RDS_{ON} at maximum junction temperature. In addition to channel loss, body diode conduction loss must be considered. Body diode conduction loss (PD_{BD}) is found using the following equation:

(Equation 32)

$$
PD_{BD(SYNC)}(W) = 2 \times I_{LOAD} \times V_F \times T_{DT} \times F_{SW}
$$

Where V_F = Body Diode Forward Voltage

 T_{DT} = PWM output dead time

 F_{SW} = PWM output switching frequency

Switching losses for the Synchronous FET are limited to the gate input losses due to the input capacitance (C_{ISS}) . PD $_{CISS}$ is found by:

(Equation 33)

 $PD_{\text{CISS(SYNC)}}(W) = 0.5 \times C_{\text{ISS}} \times (V_{\text{GS}})^2 \times F_{\text{SW}}$

Where V_{GS} = peak gate drive voltage

Most datasheets specify C_{ISS} in a graph of capacitance vs. V_{DS} . Due to the zero voltage switching of the Synchronous FET, C_{ISS} should be chosen at $V_{DS} = 0$ for this calculation.

PRODUCTION DATA SHEET

WWW.

Microsemi .

COM

APPLICATION INFORMATION

Total power loss in the Synchronous FET will be the sum of the conduction and the switching losses:

(Equation 34)

 $PD_{(SYNC)}(W) = PD_{RDS(SYNC)} + PD_{BD(SYNC)} + PD_{CISS(SYNC)}$

Switching losses in the Control FET are due to overlap switching loss, gate input loss, losses due to MOSFET capacitances, and Synchronous FET body diode reverse recovery charge.

To calculate overlap switching loss, first the average gate current must be calculated. This is found through by the average of the upper and lower drive RDS_{ON} , added to the MOSFET internal gate resistance, which is specified on most datasheets. If not specified, 2.0 Ohms may be substituted. In the LX1752, the average drive on-resistance is 3.0Ω . Average gate current can now be found by:

$$
\text{(Equation 35)} \quad I_{\text{G}} = 0.5 \times \frac{V_{\text{GS}}}{R_{\text{DRIVE}} + R_{\text{GATE}}}
$$

Where R_{DRIVE} = average controller gate drive On resistance $R_{GATE} = MOSFET gate resistance$

Once average gate current is known, the next step is to calculate the average gate switching time:

$$
\text{(Equation 36)} \quad \mathsf{T}_{\mathsf{S}} = \frac{\mathsf{Q}_{\mathsf{GS2}} + \mathsf{Q}_{\mathsf{GD}}}{\mathsf{I}_{\mathsf{G}}}
$$

Where Q_{GS2} is the portion of gate to source gate charge after the gate reaches Vth to the plateau of the gate charge curve, and Q_{GD} is MOSFET gate-drain charge. Refer to the MOSFET datasheet for more detail.

With switching time (T_S) , load current, PWM frequency, and maximum V_{IN} known, overlap switching loss can be calculated by:

(Equation 37)
$$
PD_{OLS} = I_{OUT} \times T_S \times V_{IN} \times F_{SW}
$$

Gate input loss (PD_{GATE}) is found by:

(Equation 38)

DRIVE $+$ Γ Gate $PD_{\text{GATE}} = Q_{\text{G}} \times V_{\text{GS}} \times F_{\text{SW}} \times \frac{R_{\text{GATE}}}{R_{\text{DRIVE}} + R_{\text{GATE}}}$

Where: F_{SW} = PWM switching frequency R_{GATE} = gate input resistance Where Q_G = total gate charge (datasheet value) V_{GS} = peak gate drive voltage R_{DRIVE} = high side driver on resistance

Losses due to Synchronous FET reverse body diode recovery are based on Q_{RR} , a parameter not clearly defined in most datasheets. A good rule of thumb would be to increase the total power dissipation due to switching loss by 20% to account for losses due to Q_{RR} and MOSFET capacitances. The total Control FET switching loss would be the sum of the losses, increased by 20%:

(Equation 39)

$$
PD_{SW(CONTROL)} = (PD_{OLS} + PD_{GATE}) \times 1.2
$$

Total power dissipation in the Control FET can now be calculated:

(Equation 40)

$$
PD_{\text{CONTROL}}(W) = PD_{\text{SW(CONTROL)}} + PD_{\text{RDS(CONTROL)}}
$$

Once the power dissipations of both MOSFETS are known, the operating junction temperatures can be calculated using thermal resistance specifications contained in the MOSFET datasheet.

PRINTED CIRCUIT BOARD LAYOUT RECOMMENDATIONS

Careful attention to PCB layout is necessary to insure proper operation with minimal noise generation. When laying out the PCB, these guidelines should be followed:

- 1) Keep the input capacitor, output capacitor, output inductor and output MOSFETs (upper and lower), close together, and tie all high current output returns directly to a suitable power ground plane.
- 2) Keep the high current ground return paths separate from the signal return paths. It is recommended that a separate signal ground plane be used, with a common tie point between the power ground plane and the signal ground plane established at the IC signal ground pin.
- 3) Place the input decoupling capacitor has close to the upper and lower MOSFETs as practical. Connections between this capacitor and the upper and lower MOSFET's Drain and Source connections should be as

Copyright © 2007 Rev. 1.0, 2008-07-31

Microsemi Analog Mixed Signal Group 11861 Western Avenue, Garden Grove, CA. 92841, 714-898-8121, Fax: 714-893-2570

PRODUCTION DATA SHEET

APPLICATION INFORMATION

short as practical.

- 4) The LDO filter capacitor should be placed as close to the VCCL pin as practical.
- 5) PGND connection to the Source pin of the Lower MOSFET should be as short as practical, and should be established with a direct connection (using no vias) if possible.
- 6) VS_x Pin connections should be Kelvin connected directly at the Upper MOSFET's drain pin(s).
- 7) HR_X connection to the Upper MOSFET's Source pin should be as short as practical, and should be established with a direct connection (using no vias) if possible.
- 8) LO_X and HO_X should be connected to their respective MOSFET gate pins with as short a trace as practical, and should be established with a direct connection (using no vias) if possible.
- 9) Stray capacitance to ground on CSx pins should be minimized. If possible, remove ground and power planes in the area directly below CS_x pins, and place each respective CS_x resistor as close to the LX1752 as practical; preferably on the same PCB side as the LX1752.
- 10) Place all compensation and feedback components as close to their respective error amplifier pins as practical. Keep the error amplifier input connections (EA_x-) as short as possible.
- 11) Place the frequency programming resistor, R_{FREO} as close to the RFREQ and GND pins as practical.
- 12) Refer to the Evaluation Board for an example of the PCB layout.

PRODUCTION DATA SHEET

PACKAGE DIMENSIONS

PRODUCTION DATA SHEET

NOTES

PRELIMINARY DATA – Information contained in this document is pre-production data and is proprietary to Microsemi. It may not be modified in any way without the express written consent of Microsemi. Product referred to herein is offered in pre-production form only and may not have completed Microsemi's Quality Assurance process for Release to Production. Microsemi reserves the right to change or discontinue this proposed product at any time

ООО "ЛайфЭлектроникс" "LifeElectronics" LLC

ИНН 7805602321 КПП 780501001 Р/С 40702810122510004610 ФАКБ "АБСОЛЮТ БАНК" (ЗАО) в г.Санкт-Петербурге К/С 30101810900000000703 БИК 044030703

 Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

 Мы предлагаем:

- *Конкурентоспособные цены и скидки постоянным клиентам.*
- *Специальные условия для постоянных клиентов.*
- *Подбор аналогов.*
- *Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.*
- *Приемлемые сроки поставки, возможна ускоренная поставка.*
- *Доставку товара в любую точку России и стран СНГ.*
- *Комплексную поставку.*
- *Работу по проектам и поставку образцов.*
- *Формирование склада под заказчика.*
- *Сертификаты соответствия на поставляемую продукцию (по желанию клиента).*
- *Тестирование поставляемой продукции.*
- *Поставку компонентов, требующих военную и космическую приемку.*
- *Входной контроль качества.*
- *Наличие сертификата ISO.*

 В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- *Регистрацию проекта у производителя компонентов.*
- *Техническую поддержку проекта.*
- *Защиту от снятия компонента с производства.*
- *Оценку стоимости проекта по компонентам.*
- *Изготовление тестовой платы монтаж и пусконаладочные работы.*

 Tел: +7 (812) 336 43 04 (многоканальный) Email: org@lifeelectronics.ru

www[.lifeelectronics.ru](http://lifeelectronics.ru/)